Search Notes



Application	n/Control No.	Applicant(s)/Patent Under Reexamination
10625389		IDNANI, AJAYKUMAR R.
Examiner		Art Unit
PHILIP C L	EE	2152

SEARCHED

Class	Subclass	Date	Examiner
455	456,435	6/26/08	/pl/
709	200,230,231,202,245	6/26/08	/pl/
370	338,349	6/26/08	/pl/

SEARCH NOTES

Search Notes	Date	Examiner
Consulted with SPE: Bunjob Jaroenchonwanit regarding allowable subject matter	3/21/07	/pl/
Keywords Search in 455/456, 435; 709/200,230,231,202,245; 370/338,349 in EAST	2/13/08	/pl/
Search in 455/456, 435; 709/200,230,231,202,245; 370/338,349 in PG Pub	2/13/08	/pl/
Google Search	2/13/08	/pl/
ACM/IEEE Search	2/13/08	/pl/
Keywords Search in 455/456, 435; 709/200,230,231,202,245; 370/338,349 in EAST	6/26/08	/pl/
Search in 455/456, 435; 709/200,230,231,202,245; 370/338,349 in PG Pub	6/26/08	/pl/
Google Search	7/2/08	/pl/
ACM/IEEE Search	7/2/08	/pl/
Consulted with SPE: John Follansbee regarding 112th, second paragraph	6/27/08	/pl/

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
455	456,435	2/13/08	/pl/
370	338,349	2/13/08	/pl/
709	200,202,230,231,245	2/13/08	/pl/
455	456,435	6/26/08	/pl/
370	338,349	6/26/08	/pl/
709	200,202,230,231,245	6/26/08	/pl/

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